

Search Notes

Application/Control No.

10/621,165

Examiner

Viet Q. Nguyen

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2827

SEARCHED

Class	Subclass	Date	Examiner
365	226	3/22/2005	V.N
323	313 314	3/22/2005	V.N
327	538	3/22/2005	V.N

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
365	226	3/28/2005	V.N

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST	3/22/2005	V.N